## Notice of References Cited Application/Control No. 10/687,646 Examiner Melur Ramakrishnaiah Applicant(s)/Patent Under Reexamination OHKAWA ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	· N	JP 06-261316	09-1994	Japan	Wakahara et al.	H04N 7/15
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

·							
* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U						
	>						
	w						
	х	,					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.